

Search Notes



Application/Control No.

10/757,156

Examiner

J. Derek Rutten

**Applicant(s)/Patent under
Reexamination**

DEWITT ET AL.

Art Unit

2192

SEARCHED

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
See Search Notes		6/19/2007	JDR

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST (US-PGPUB; USPAT; EPO; JPO; IBM_TDB; DERWENT) - see search history printout	6/14/2007	JDR
717/130-133,151-153,155,156,158-160; 712/233-244; 714/35,46 Text search only See search history printout	6/14/2007	JDR
ACM - portal.acm.org IEEE - ieeexplore.ieee.org See search history printout	6/14/2007	JDR
Tuan Dam, SPE 2192 (consulted re. allowable subject matter)	6/14/2007	JDR
717/130,158,159; 712/240; 714/45 text search only See search history printout	6/19/2007	JDR